

TO-251 Plastic-Encapsulated Transistors

3DD13001

TRANSISTOR (NPN)

FEATURES

Power dissipation

P_{CM} : 1.2 W ($T_{amb}=25^{\circ}C$)

Collector current

I_{CM} : 0.2 A

Collector-base voltage

$V_{(BR)CBO}$: 600 V

Operating and storage junction temperature range

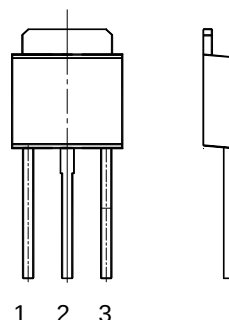
T_J, T_{stg} : $-55^{\circ}C$ to $+150^{\circ}C$

TO-251

1. BASE

2. COLLECTOR

3. EMITTER



ELECTRICAL CHARACTERISTICS ($T_{amb}=25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Collector-base breakdown voltage	$V_{(BR)CBO}$	$I_C = 100\mu A, I_E = 0$	600			V
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C = 1\text{ mA}, I_B = 0$	400			V
Emitter-base breakdown voltage	$V_{(BR)EBO}$	$I_E = 100\mu A, I_C = 0$	7			V
Collector cut-off current	I_{CBO}	$V_{CB} = 600\text{ V}, I_E = 0$			100	μA
Collector cut-off current	I_{CEO}	$V_{CE} = 400\text{ V}, I_B = 0$			200	μA
Emitter cut-off current	I_{EBO}	$V_{EB} = 7\text{ V}, I_C = 0$			100	μA
DC current gain	$h_{FE(1)}$	$V_{CE} = 20\text{ V}, I_C = 20\text{ mA}$	10		40	
	$h_{FE(2)}$	$V_{CE} = 10\text{ V}, I_C = 0.25\text{ mA}$	5			
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = 50\text{ mA}, I_B = 10\text{ mA}$			0.5	V
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C = 50\text{ mA}, I_B = 10\text{ mA}$			1.2	V
Base-emitter voltage	V_{BE}	$I_E = 100\text{ mA}$			1.1	V
Transition frequency	f_T	$V_{CE} = 20\text{ V}, I_C = 20\text{ mA}$ $f = 1\text{ MHz}$	8			MHz
Fall time	t_f	$I_C = 50\text{ mA}, I_{B1} = -I_{B2} = 5\text{ mA}$			0.3	μs
Storage time	t_s	$V_{CC} = 45\text{ V}$			1.5	μs

CLASSIFICATION OF $h_{FE(1)}$

Rank						
Range	10-15	15-20	20-25	25-30	30-35	35-40